

<b>Notice of References Cited</b>	Application/Control No. 10/081,020		Applicant(s)/Patent Under Reexamination FUNG ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,684,964	11-1997	Powers et al.	705/11
*	B	US-5,726,914	03-1998	Janovski et al.	702/84
*	C	US-6,119,097	09-2000	Ibarra, David	705/11
*	D	US-6,324,282	11-2001	McIlwaine et al.	379/265.06
*	E	US-6,970,810	11-2005	Matsko, Michael J.	702/187
*	F	US-7,093,748	08-2006	Matsko et al.	235/377
*	G	US-2001/0032120	10-2001	Stuart et al.	705/11
*	H	US-2001/0032195	10-2001	Graichen et al.	705/400
*	I	US-2002/0038235	03-2002	Musafia et al.	705/11
*	J	US-2001/0056367	12-2001	Herbert et al.	705/11
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Fitz-Enz, Jac, The Mythology of Measuring Staff Performance Canadian Business Review, Vol. 20, No. 1, Sprin 1993
	V	Jones, Steven D., Work Group Performance Measurement and Feedback Group & Organization Studies, September 1993, Vol. 18, No. 3
	W	Jacobs, Bill, Operating stores: High octane execution Chain Store Age with Shopping Center Age, Vol. 70, No. 1, January 1994
	X	Achieving Organizational Excellenace Through the Performamnce Measurement System American Productivity & Quality Center, 1999

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Turnind data in knowledge Chain Store Age, January 1996
	V	Donthu, Naveen et al., Retail Productivity Assessment Using Data Envelope Analysis Journal of Retailing; Vol. 74, No. 1, Sprin 1998
	W	Jensen, Anne J. et al., A Systems Management Approach for Improvement of Organization Performancce Measurement Systems Information-Knowledge-Systems Management, Vol. 2, No. 2, January 2000
	X	Simons, Robert, Performance Measurement & Control Systems for Implementing Strategy Prentice Hall, 2000, ISBN: 0-13-234006-2

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.